## LOW VOLTAGE QUAD 2 CHANNEL MULTIPLEXER WITH 5V TOLERANT INPUTS AND OUTPUTS (3-STATE)

- 5V TOLERANT INPUTS AND OUTPUTS
- HIGH SPEED:
tpd $=6.0 \mathrm{~ns}$ (MAX.) at $\mathrm{Vcc}=3 \mathrm{~V}$
- POWER-DOWN PROTECTION ON INPUTS AND OUTPUTS
- SYMMETRICAL OUTPUT IMPEDANCE: $|\mathrm{lOH}|=\mathrm{l}_{\mathrm{OL}}=24 \mathrm{~mA}$ (MIN)
- PCI BUS LEVELS GUARANTEED AT 24mA
- BALANCED PROPAGATIONDELAYS: tPLH $\cong$ tph
- OPERATING VOLTAGE RANGE:
$\mathrm{V}_{\mathrm{CC}}(\mathrm{OPR})=2.0 \mathrm{~V}$ to 3.6 V (1.5V Data Retention)
- PIN AND FUNCTION COMPATIBLE WITH 74 SERIES 257
- LATCH-UP PERFORMANCE EXCEEDS 500mA
- ESD PERFORMANCE:

HBM $>2000 \mathrm{~V}$; MM > 200V

## DESCRIPTION

The 74LCX257 is a low voltage CMOS QUAD 2 CHANNEL MULTIPLEXER (3-STATE) fabricated with sub-micron silicon gate and double-layer metal wiring $\mathrm{C}^{2} \mathrm{MOS}$ technology. It is ideal for low power and high speed 3.3 V applications. It can be interfaced to 5 V signal environment for both inputs and outputs.


It is composed of four independent 2 channel multiplexers with common SELECT and ENABLE INPUT. The 74 VHC 257 is a non inverting multiplexer.
When the ENABLE INPUT is held "High", all outputs become high impedance state. If SELECT INPUT is held "Low", "A" data is selected, when SELECT INPUT is "High", "B" data is chosen. It has same speed performance at 3.3 V than 5 V , $\mathrm{AC} / \mathrm{ACT}$ family, combined with a lower power consumption.
All inputs and outputs are equipped with protection circuits against static discharge, giving them 2KV ESD immunity and transient excess voltage.

PIN CONNECTION AND IEC LOGIC SYMBOLS


INPUT AND OUTPUT EQUIVALENT CIRCUIT


PIN DESCRIPTION

| PIN No | SYMBOL | NAME AND FUNCTION |
| :---: | :---: | :--- |
| 1 | SELECT | Common Data Select Input |
| $2,5,14,11$ | 1 A to 4A | Data Input From Source A |
| $3,6,13,10$ | $1 B$ to 4B | Data Inputs from Source B |
| $4,7,12,9$ | $1 Y$ to 4Y | 3 State Multiplexer Outputs |
| 15 | $\overline{\mathrm{OE}}$ | 3 State Output Enable <br> Inputs (Active LOW) |
| 8 | GND | Ground (OV) |
| 16 | V $_{\mathrm{CC}}$ | Positive Supply Voltage |

TRUTH TABLE

| INPUTS |  |  |  | OUTPUTS |
| :---: | :---: | :---: | :---: | :---: |
| $\overline{\mathbf{O E}}$ | SELECT | $\mathbf{A}$ | $\mathbf{B}$ | Y |
| H | X | X | X | Z |
| L | L | L | X | L |
| L | L | H | X | H |
| L | H | X | L | L |
| L | H | X | H | H |

LOGIC DIAGRAM


This logic diagram has notbe used to estimate propagation delays

ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply Voltage | -0.5 to +7.0 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | DC Input Voltage | -0.5 to +7.0 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | DC Output Voltage (OFF State) | -0.5 to +7.0 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | DC Output Voltage (High or Low State) (note1) | -0.5 to $\mathrm{V}_{\mathrm{CC}}+0.5$ | V |
| $\mathrm{I}_{\mathrm{K}}$ | DC Input Diode Current | -50 | mA |
| $\mathrm{I}_{\mathrm{OK}}$ | DC Output Diode Current (note2) | $\pm 50$ | mA |
| $\mathrm{I}_{\mathrm{O}}$ | DC Output Source/Sink Current | $\pm 50$ | mA |
| $\mathrm{I}_{\mathrm{CC}}$ | DC Supply Current per Supply Pin | $\pm 100$ | mA |
| $\mathrm{I}_{\mathrm{GND}}$ | DC Ground Current per Supply Pin | $\pm 100$ | mA |
| $\mathrm{~T}_{\text {stg }}$ | Storage Temperature | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{L}}$ | Lead Temperature (10 sec) | 300 | ${ }^{\circ} \mathrm{C}$ |

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.

1) Io absolute maximum rating must be observed
2) $V_{o}<G N D, V_{O}>V_{c c}$

## RECOMMENDED OPERATING CONDITIONS

| Symbol | Parameter | Value | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply Voltage (note 1$)$ | 2.0 to 3.6 | V |
| $\mathrm{~V}_{\mathrm{I}}$ | Input Voltage | 0 to 5.5 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | Output Voltage (Off State) | 0 to 5.5 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | Output Voltage (High or Low State) | 0 to $\mathrm{V}_{\mathrm{CC}}$ | V |
| $\mathrm{I}_{\mathrm{OH}}, \mathrm{l}_{\mathrm{OL}}$ | High or Low Level Output Current $\left(\mathrm{V}_{\mathrm{CC}}=3.0\right.$ to 3.6 V$)$ | $\pm 24$ | mA |
| $\mathrm{I}_{\mathrm{OH}}, \mathrm{I}_{\mathrm{OL}}$ | High or Low Level Output Current $\left(\mathrm{V}_{\mathrm{CC}}=2.7\right.$ to 3.0 V$)$ | $\pm 12$ | mA |
| $\mathrm{~T}_{\mathrm{Op}}$ | Operating Temperature: | -40 to +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{dt} / \mathrm{dv}$ | Input Transition Rise or Fall Rate $\left(\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}\right)$ (note 2$)$ | 0 to 10 | $\mathrm{~ns} / \mathrm{V}$ |

1) Truth Table guaranteed: 1.5 V to 3.6 V
2) V in from 0.8 V to 2.0 V

DC SPECIFICATIONS

| Symbol | Parameter | Test Conditions |  |  | Value |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{cc}} \\ & (\mathrm{~V}) \end{aligned}$ |  |  | -40 to $85{ }^{\circ} \mathrm{C}$ |  |  |
|  |  |  |  |  | Min. | Max. |  |
| $\mathrm{V}_{\mathrm{IH}}$ | High Level Input Voltage | 2.7 to 3.6 |  |  | 2.0 |  | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Low Level Input Voltage |  |  |  |  | 0.8 | V |
| $\mathrm{V}_{\mathrm{OH}}$ | High Level Output Voltage | 2.7 to 3.6 | $V_{1}=$ <br> $\mathrm{V}_{\mathrm{IH}}$ or <br> $V_{\text {IL }}$ | $\mathrm{I}_{\mathrm{O}}=-100 \mu \mathrm{~A}$ | $\mathrm{V}_{\mathrm{CC}}-0.2$ |  | V |
|  |  | 2.7 |  | $\mathrm{I}_{\mathrm{O}}=-12 \mathrm{~mA}$ | 2.2 |  |  |
|  |  | 3.0 |  | $\mathrm{I}_{\mathrm{O}}=-18 \mathrm{~mA}$ | 2.4 |  |  |
|  |  |  |  | $\mathrm{l}=-24 \mathrm{~mA}$ | 2.2 |  |  |
| VoL | Low Level Output Voltage | 2.7 to 3.6 | $V_{1}=$ <br> $\mathrm{V}_{\text {IH }}$ or VIL | $\mathrm{I}_{0}=100 \mu \mathrm{~A}$ |  | 0.2 | V |
|  |  | 2.7 |  | $\mathrm{I}_{\mathrm{O}}=12 \mathrm{~mA}$ |  | 0.4 |  |
|  |  | 3.0 |  | $\mathrm{I}_{\mathrm{O}}=16 \mathrm{~mA}$ |  | 0.4 |  |
|  |  | 3.0 |  | $\mathrm{I}_{\mathrm{O}}=24 \mathrm{~mA}$ |  | 0.55 |  |
| 1 | Input Leakage Current | 2.7 to 3.6 | $\mathrm{V}_{1}=$ | to 5.5 V |  | $\pm 5$ | $\mu \mathrm{A}$ |
| $\mathrm{l}_{\text {off }}$ | Power Off Leakage Current | 0 | $V_{1}$ or | $\mathrm{V}=5.5 \mathrm{~V}$ |  | 10 | $\mu \mathrm{A}$ |
| loz | 3 State Output Leakage Current | 2.7 to 3.6 |  | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{H}} \text { or } \mathrm{V}_{\mathrm{IL}} \\ & 0 \text { to } 5.5 \mathrm{~V} \end{aligned}$ |  | $\pm 5$ | $\mu \mathrm{A}$ |
| ICC | Quiescent Supply Current | 2.7 to 3.6 | $\mathrm{V}_{1}=\mathrm{V}^{\prime}$ | co or GND |  | 10 | $\mu \mathrm{A}$ |
|  |  |  |  | $\begin{aligned} & \text { or } \mathrm{V}_{\mathrm{O}}= \\ & \text { to } 5.5 \mathrm{~V} \end{aligned}$ |  | $\pm 10$ |  |
| $\Delta \mathrm{lcc}$ | ICC incr. per input | 2.7 to 3.6 | $\mathrm{V}_{1 \mathrm{H}}=$ | $\mathrm{Vcc}-0.6 \mathrm{~V}$ |  | 500 | $\mu \mathrm{A}$ |

DYNAMIC SWITCHING CHARACTERISTICS ( $C \mathrm{~L}=50 \mathrm{pF}$, RL=500 $\Omega$ )

| Symbol | Parameter | Test Conditions |  | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{cc}} \\ & (\mathrm{~V}) \end{aligned}$ |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  |  |
|  |  |  |  | Min. | Typ. | Max. |  |
| Volp | Dynamic Low Voltage Quiet Output | 3.3 | $\mathrm{V}_{\mathrm{IL}}=0 \mathrm{~V}$ |  | 0.8 |  |  |
| $\mathrm{V}_{\text {OLV }}$ | (note 1) |  | $\mathrm{V}_{1 H}=3.3 \mathrm{~V}$ |  | -0.8 |  |  |

1) Number of outputs defined as" $n$ ". Measured with" $n$-1" outputs switching from HIGH to LOW or LOW t oHIGH. The remaining output is measured in the LOW state.

AC ELECTRICAL CHARACTERISTICS ( $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=500 \Omega$, Input $\left.\mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=2.5 \mathrm{~ns}\right)$

| Symbol | Parameter | Test Condition |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\mathrm{V}_{\mathrm{cc}}$ <br> (V) | Waveform | -40 to $85{ }^{\circ} \mathrm{C}$ |  |  |
|  |  |  |  | Min. | Max. |  |
| $\begin{aligned} & \hline \text { tpLH } \\ & \text { tpHL } \end{aligned}$ | Propagation Delay Time A, B to Y | 2.7 | 2 | 1.5 | 6.5 | ns |
|  |  | 3.0 to 3.6 |  | 1.5 | 6.0 |  |
| $\begin{aligned} & \hline \mathrm{tpLH}^{\mathrm{t} P \mathrm{~L}} \end{aligned}$ | Propagation Delay Time SELECT to Y | 2.7 | 1, 2 | 1.5 | 8.5 | ns |
|  |  | 3.0 to 3.6 |  | 1.5 | 7.0 |  |
| $\begin{aligned} & \text { tpzL } \\ & \mathrm{t}_{\text {PzH }} \end{aligned}$ | Output Enable Time | 2.7 | 3 | 1.5 | 8.5 | ns |
|  |  | 3.0 to 3.6 |  | 1.5 | 7.0 |  |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PLLZ}} \\ & \mathrm{t}_{\mathrm{Phz}} \end{aligned}$ | Output Disable Time | 2.7 | 3 | 1.5 | 6.0 | ns |
|  |  | 3.0 to 3.6 |  | 1.5 | 5.5 |  |
| tosLh <br> toshl | Output to Output Skew Time (note 1, 2) | 3.0 to 3.6 |  |  | 1.0 | ns |

1) Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs of the same device switching in the
same direction, either HIGHor LOW ( $\mathrm{t}_{\mathrm{OLLH}}=\left|\mathrm{t}_{\mathrm{PLHm}}-\mathrm{t}_{\text {PLHn }}\right|, \mathrm{tosh}=\left|\mathrm{t}_{\text {PHLm }}-\mathrm{t}_{\text {pHLn }}\right|$ )
2) Parameter guaranteed by design

## CAPACITIVE CHARACTERISTICS

| Symbol | Parameter | Test Conditions |  | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $V_{c c}$ <br> (V) |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  |  |
|  |  |  |  | Min. | Typ. | Max. |  |
| $\mathrm{C}_{\text {IN }}$ | Input Capacitance | 3.3 | $\mathrm{V}_{\mathrm{IN}}=0$ to $\mathrm{V}_{\mathrm{CC}}$ |  | 7 |  | pF |
| Cout | Output Capacitance | 3.3 | $\mathrm{V}_{\mathrm{IN}}=0$ to $\mathrm{V}_{\mathrm{CC}}$ |  | 8 |  | pF |
| $\mathrm{C}_{\text {PD }}$ | Power Dissipation Capacitance (note 1) | 3.3 | $\begin{aligned} \mathrm{f}_{\mathrm{IN}} & =10 \mathrm{MHz} \\ \mathrm{~V}_{\mathrm{IN}} & =0 \text { or } \mathrm{V}_{\mathrm{CC}} \end{aligned}$ |  | 25 |  | pF |

1) CpD isdefined as the value of the IC'sinternal equivalent capacitance which is calculated from the operating current consumption without load. Average operting current can be obtained by the following equation. $\mathrm{I}_{\mathrm{CC}}(\mathrm{opr})=\mathrm{C}_{\mathrm{PD}} \bullet \mathrm{V}_{\mathrm{CC}} \bullet \mathrm{fiN}_{\mathrm{IN}}+\mathrm{I}_{\mathrm{CO}} 4$ (per channel)

## TEST CIRCUIT



| TEST | SWITCH |
| :--- | :---: |
| $t_{\text {PLH }}, t_{\text {PHL }}$ | Open |
| $t_{\text {PZL }}, t_{\text {PLZ }}$ | 6V |
| $t_{\text {PZH, }}, t_{\text {PHZ }}$ | GND |

$\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ or equivalent (includes jig and probe capacitance)
$R_{L}=R_{1}=500 \Omega$ orequivalent
$\mathrm{R}_{\mathrm{T}}=$ Zour of pulse generator (typically $50 \Omega$ )

WAVEFORM 1: PROPAGATION DELAYS FOR INVERTING CONDITIONS ( $\mathrm{f}=1 \mathrm{MHz} ; 50 \%$ duty cycle)


WAVEFORM 2: PROPAGATION DELAYS FOR NON-INVERTING CONDITIONS ( $f=1 \mathrm{MHz} ; 50 \%$ duty cycle)


WAVEFORM 3: OUTPUT ENABLE AND DISABLE TIME (f=1MHz; 50\% duty cycle)


## SO-16 MECHANICAL DATA

| DIM. | mm |  |  | inch |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A |  |  | 1.75 |  |  | 0.068 |
| a1 | 0.1 |  | 0.2 | 0.004 |  | 0.007 |
| a2 |  |  | 1.65 |  |  | 0.064 |
| b | 0.35 |  | 0.46 | 0.013 |  | 0.018 |
| b1 | 0.19 |  | 0.25 | 0.007 |  | 0.010 |
| C |  | 0.5 |  |  | 0.019 |  |
| c1 | 45 (typ.) |  |  |  |  |  |
| D | 9.8 |  | 10 | 0.385 |  | 0.393 |
| E | 5.8 |  | 6.2 | 0.228 |  | 0.244 |
| e |  | 1.27 |  |  | 0.050 |  |
| e3 |  | 8.89 |  |  | 0.350 |  |
| F | 3.8 |  | 4.0 | 0.149 |  | 0.157 |
| G | 4.6 |  | 5.3 | 0.181 |  | 0.208 |
| L | 0.5 |  | 1.27 | 0.019 |  | 0.050 |
| M |  |  | 0.62 |  |  | 0.024 |
| S | 8 (max.) |  |  |  |  |  |



TSSOP16 MECHANICAL DATA

| DIM. | mm |  |  | inch |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A |  |  | 1.1 |  |  | 0.433 |
| A1 | 0.05 | 0.10 | 0.15 | 0.002 | 0.004 | 0.006 |
| A2 | 0.85 | 0.9 | 0.95 | 0.335 | 0.354 | 0.374 |
| b | 0.19 |  | 0.30 | 0.0075 |  | 0.0118 |
| C | 0.09 |  | 0.20 | 0.0035 |  | 0.0079 |
| D | 4.9 | 5 | 5.1 | 0.193 | 0.197 | 0.201 |
| E | 6.25 | 6.4 | 6.5 | 0.246 | 0.252 | 0.256 |
| E1 | 4.3 | 4.4 | 4.48 | 0.169 | 0.173 | 0.176 |
| e |  | 0.65 BSC |  |  | 0.0256 BSC |  |
| K | $0^{\circ}$ | $4^{\circ}$ | $8^{\circ}$ | $0^{\circ}$ | $4^{\circ}$ | $8^{\circ}$ |
| L | 0.50 | 0.60 | 0.70 | 0.020 | 0.024 | 0.028 |



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